Unit: mm

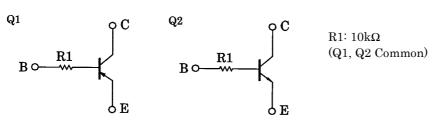
TOSHIBA Transistor Silicon PNP Epitaxial Type (PCT Process) Silicon NPN Epitaxial Type (PCT Process)

# RN4911

#### Switching, Inverter Circuit, Interface Circuit And Driver Circuit Applications

- Includeing two devices in US6 (ultra super mini type with 6 leads)
- With built-in bias resistors
- Simplify circuit design
- Reduce a quantity of parts and manufacturing process

#### **Equivalent Circuit and Bias Resister Values**



#### Q1 Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	$V_{CBO}$	-50	V
Collector-emitter voltage	V <sub>CEO</sub>	-50	V
Emitter-base voltage	V <sub>EBO</sub>	-5	V
Collector current	Ic	-100	mA

### $1.25 \pm 0.1$ EMITTER 1 BASE 1 COLLECTOR 2 (E1)(B1) (C2)EMITTER 2 (E2) BASE 2 (B2)US6 COLLECTOR 1 (C1) **JEDEC** EIAJ **TOSHIBA** 2-2J1A

 $2.1 \pm 0.1$ 

Weight: 6.8mg

#### Q2 Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	$V_{CBO}$	50	٧
Collector-emitter voltage	V <sub>CEO</sub>	50	٧
Emitter-base voltage	V <sub>EBO</sub>	5	٧
Collector current	IC	100	mA

2001-06-07

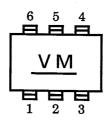
1

## Q1, Q2 Common Maximum Ratings (Ta = 25°C)

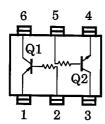
Characteristic	Symbol	Rating	Unit
Collector power dissipation	P <sub>C</sub> *	200	mW
Junction temperature	Tj	150	°C
Storage temperature range	T <sub>stg</sub>	-55~150	°C

<sup>\*</sup> Total rating

### Marking



### **Equivalent Circuit (Top View)**



2

## Q1 Electrical Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	_	$V_{CB} = -50V, I_E = 0$	_	_	-100	nA
Emitter cut-off current	I <sub>EBO</sub>	_	V <sub>EB</sub> = -5V, I <sub>C</sub> = 0	_	_	-100	mA
DC current gain	h <sub>FE</sub>	_	$V_{CE} = -5V, I_{C} = -1mA$	120	_	400	_
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	_	$I_C = -5mA$ , $I_B = -0.25mA$	_	-0.1	-0.3	V
Transition frequency	f <sub>T</sub>	_	$V_{CE} = -10V, I_{C} = -5mA$	_	200	_	MHz
Collector output capacitance	C <sub>ob</sub>	_	$V_{CB} = -10V$ , $I_E = 0$ , $f = 1MHz$	_	3	6	pF

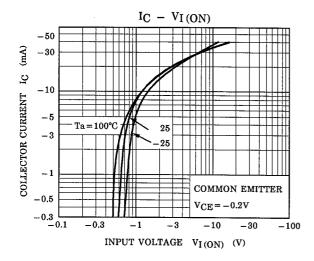
#### **Q2 Electrical Characteristics (Ta = 25°C)**

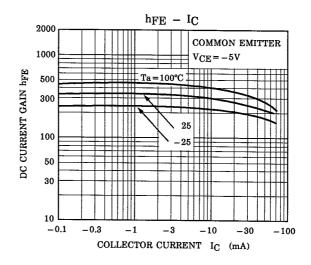
Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I <sub>CBO</sub>	_	V <sub>CB</sub> = 50V, I <sub>E</sub> = 0	_	_	100	nA
Emitter cut-off current	I <sub>EBO</sub>	_	$V_{EB} = 5V, I_C = 0$	_	_	100	mA
DC current gain	h <sub>FE</sub>	_	$V_{CE}$ = 5V, $I_C$ = 1mA	120	_	700	-
Collector-emitter saturation voltage	V <sub>CE (sat)</sub>	_	I <sub>C</sub> = 5mA, I <sub>B</sub> = 0.25mA	_	0.1	0.3	V
Transition frequency	f <sub>T</sub>	_	V <sub>CE</sub> = 10V, I <sub>C</sub> = 5mA	_	250	_	MHz
Collector output capacitance	C <sub>ob</sub>	_	V <sub>CB</sub> = 10V, I <sub>E</sub> = 0, f = 1 MHz	_	3	6	pF

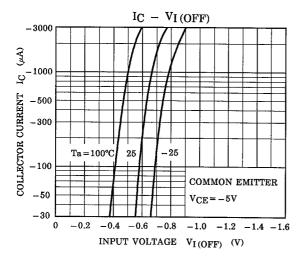
### Q1, Q2 Common Electrical Characteristics (Ta = 25°C)

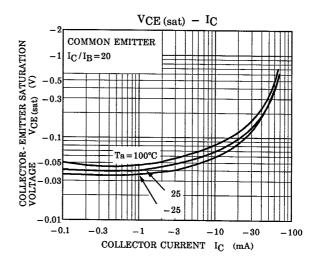
Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Input resistor	R1	_	_	7	10	13	kΩ

Q1



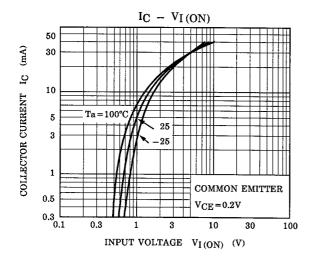


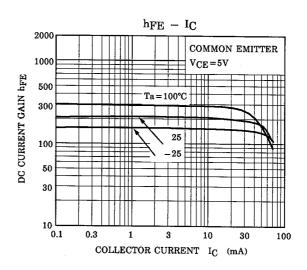


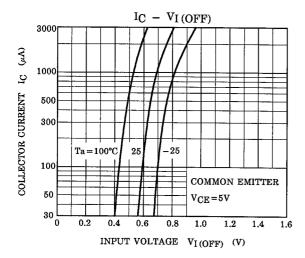


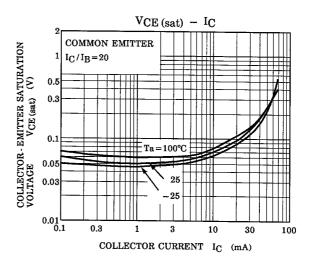
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Q2









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